

<b>Notice of References Cited</b>	Application/Control No. 10/521,658		Applicant(s)/Patent Under Reexamination VAN DER AA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0024919	02-2002	Lee et al.	369/112.24
*	B	US-2003/0035361	02-2003	Knight et al.	369/112.24
	C	US-			
	D	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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